Searcn .	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/900,280	LUO ET AL.	
Examiner	Art Unit	_
JEAN B ELEURANTIN	2162	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10	4/18/2006	JBF
707	100-104.1	4/18/2006	JBF
707	200-206	4/18/2006	JBF
709	217	4/21/2006	JBF
709	219	4/21/2006	JBF
715	529	4/21/2006	JBF

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
707	100	4/17/2006	JBF	
707	2, 104.1	4/17/2006	JBF	
707	203	4/17/2006	JBF	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	4/18/2006	JBF
707/CCLS AND 709/CCLS AND 715/CCLS AND ALL RELATED APPLICATIONS FOR POSSIBLE DOUBLE PATENTING	4/20/2006	JBF
NPL - ACM	4/20/2006	JBF
NPL - IEEE	4/20/2006	JBF
CONSULTED - TOAS DOUBLE PATENTING HELP PANEL PAT SALCE	4/17/2006	JBF
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